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| Notice of References Cited | Application/Control No. 10/781,446 | Applicant(s)/Patent Under Reexamination 4660RADBURN ET AL. | |
| | Examiner Jeffrey J. Chow | Art Unit 2672 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-4,660,037 | 04-1987 | Nakamura, Yukinobu | 340/990 |
| * | B | US-4,815,012 | 03-1989 | Feintuch, Martin | 340/995.18 |
| * | C | US-4,972,319 | 11-1990 | Delorme, David M. | 340/990 |
| * | D | US-5,369,577 | 11-1994 | Kadashevich et al. | 704/9 |
| * | E | US-5,689,343 | 11-1997 | Loce et al. | 358/3.21 |
| * | F | US-5,902,347 | 05-1999 | Backman et al. | 701/200 |
| * | G | US-5,936,616 | 08-1999 | Torborg et al. | 345/555 |
| * | H | US-6,021,433 | 02-2000 | Payne et al. | 709/219 |
| * | I | US-6,031,544 | 02-2000 | Yhann, Stephan | 345/620 |
| * | J | US-6,064,407 | 05-2000 | Rogers, Philip J. | 345/568 |
| * | K | US-6,104,416 | 08-2000 | McGuinness, Peter J. | 345/544 |
| * | L | US-6,262,741 | 07-2001 | Davies, Frederick Bryan | 345/423 |
| * | M | US-6,278,432 | 08-2001 | Ratnakar, Viresh | 715/748 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/781,446 | Applicant(s)/Patent Under Reexamination RADBURN ET AL. | |
| | Examiner Jeffrey J. Chow | Art Unit 2672 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-6,396,503 | 05-2002 | Goss et al. | 345/582 |
| * | B | US-6,429,949 | 08-2002 | Dziesietnik et al. | 358/1.16 |
| * | C | US-6,650,326 | 11-2003 | Huber et al. | 345/428 |
| * | D | US-6,873,329 | 03-2005 | Cohen et al. | 345/501 |
| * | E | US-6,724,382 | 04-2004 | Kenyon et al. | 345/419 |
| * | F | US-6,912,695 | 06-2005 | Ernst et al. | 715/792 |
| * | G | US-2005/0116966 | 06-2005 | Graham et al. | 345/661 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | W | |
| | X | |

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